# Results Chapter: Compton Edges

**Ruth Jacobs** 

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# **Strategy**



Energy [GeV]

ξ

# **Fastsim**

from Sasha's slides



- parametrization of the magnetic field using formula for  $rac{(x)}$ , x(r)
- encapsulated read-in Tonys of MC (\*.out files, \*.stdhep files can be added), based on Sasha's code in lcpolmc
- simple detector parametrization (position, span, photodetector)
- somehow now getting similar to lcpolmc, but no more dependence on ancient fortran-style random generators
- code here: <a href="https://stash.desy.de/projects/BREM/repos/fastsimsuite/browse">https://stash.desy.de/projects/BREM/repos/fastsimsuite/browse</a>

# **Acceptance x Efficiency & Resolution**

- acceptance: driven by span of the detector
- efficiency: photodetector quantum efficiency ( $\lambda$  -dependent)
  - channel reflectivity
  - filter transmission

 $\kappa = \int_{\lambda}^{\lambda} \max_{\substack{QE(\lambda) \\ \text{min}}} QE(\lambda) \cdot \epsilon_{\text{refl}} \cdot \epsilon_{\text{filter}}$ 

• resolution: driven by segmentation of the detector



# **Edge Finding?**

#### **Differentiation Prescription**

- get electron x distribution
- calculate slope bin-by-bin (average over (i,i-1) and (i,i+1)



- find the bin with minimum slope
  → edge
- in reality need to define a window where to look for the first edge
- for high xi this gets difficult, as you get closer to the beam



# **Statistical Uncertainty**

- Statistical: "On average, a primary electron leaves 8 Cerenkov photons"
  → Poissonian errors
- Toy approach: vary count rates in pseudo-experiments, rederive edges



# **Systematic Uncertainties**

- LASER intensity
  - assume  $1/sqrt(1+\xi^2)$  behaviour
- Misalignment
  - few percent effect, neglect
- Non-linearities (photo-detector, readout electronics):
  - has been measured for prototype setup (thesis C. Helebrandt
  - few percent effect
  - test for SiPMs!
- Backgrounds: need to understand
- something I forgot?



10% LASER uncertainty  $\rightarrow$  20% uncertainty on edge position at low  $\xi$